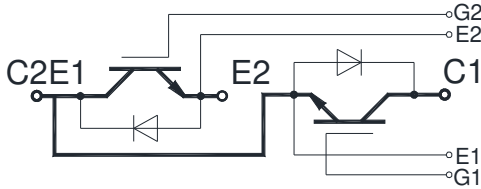




## MRI200.17

### 2 in 1 IGBT Modules



#### Features:

- Low  $V_{CE(sat)}$  trench IGBT technology
- Low switching losses
- 10 $\mu$ s short circuit capability
- $V_{CE(sat)}$  with positive temperature coefficient

#### Typical Applications:

- AC inverter drives mains 575-750V AC
- Public transport (auxiliary syst.)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT
			Min	Type	Max	
$V_{CES}$	Collector-Emitter voltage	$T_j=25^\circ\text{C}$			1700	V
$V_{GES}$	Gate-Emitter voltage	$T_j=25^\circ\text{C}$			$\pm 20$	V
$I_c$	Collector current	Continuous@ $T_c=80^\circ\text{C}$			200	A
$I_{CP}$		$T_P=1\text{ms}$			400	A
$P_D$	Maximum Power Dissipation	$T_j=175^\circ\text{C}, 1\text{ device}$			1515	W
$T_j$	Junction temperature	/			175	$^\circ\text{C}$
$T_{stg}$	Storage temperature	/	-40		125	$^\circ\text{C}$
$V_{iso}$	Isolation between terminal and copper base	$T_j=25^\circ\text{C}, \text{AC: } 1\text{minute}$	4000			V
Screw torque	Mounting(M6)	/	2.5		5.0	N·m
	Terminals(M6)	/	3.0		5.0	N·m
$I_{CES}$	Zero gate voltage collector current	$T_j=25^\circ\text{C}, V_{CE}=1700\text{V}, V_{GE}=0\text{V}$			3.0	mA
$I_{GES}$	Gate-Emitter leakage current	$T_j=25^\circ\text{C}, V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}$			$\pm 0.4$	$\mu\text{A}$
$V_{GE(th)}$	Gate-Emitter threshold voltage	$T_j=25^\circ\text{C}, V_{CE}=20\text{V}, I_c=8\text{mA}$	5.2	5.8	6.4	V
$V_{CE(sat)}$	Collector-Emitter saturation voltage	$T_j=25^\circ\text{C}, V_{GE}=15\text{V}, I_c=200\text{A}$		2.0		V
		$T_j=125^\circ\text{C}, V_{GE}=15\text{V}, I_c=200\text{A}$		2.4		V
$R_{Gint}$	Internal gate resistor	$T_j=25^\circ\text{C}$		3.8		$\Omega$
$C_{ies}$	Input capacitance	$T_j=25^\circ\text{C}, V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		18.0		nF
$C_{res}$	Reverse transfer capacitance			0.60		nF
$t_{on}$	Turn-on time	$T_j=125^\circ\text{C}, V_{CC}=900\text{V}, I_c=200\text{A}, V_{GE}=\pm 15\text{V}, R_g=6.8\Omega, \text{ Inductive load}$		310		ns
$t_r$				98		ns
$t_{off}$	Turn-off time			1008		ns
$t_f$				202		ns
$E_{on}$	Turn-on energy loss per pulse			78		mJ
$E_{off}$	Turn-off energy loss per pulse			63		mJ
$I_{SC}$	SC data	$t_{sc} \leq 10 \mu\text{s}, V_{GE}=15\text{V}, T_j=125^\circ\text{C}, V_{CC}=1000\text{V}, V_{CEM} \leq 1700\text{V}$		800		A
$t_{sc}$	Short circuit withstand time	$T_j=125^\circ\text{C}$	10			$\mu\text{s}$

$V_F$	Forward on voltage	$T_J=25^\circ\text{C}, I_F=200\text{A}$	1.8	V
		$T_J=125^\circ\text{C}, I_F=200\text{A}$	1.9	V
$I_{RM}$	Peak reverse recovery current	$I_F=200\text{A}, -diF/dt=3600\text{A}/\mu\text{s}, V_R=900\text{V}, V_{GE}=-15\text{V}, T_J=125^\circ\text{C}$	231	A
$Q_r$	Recovered charge		85.4	$\mu\text{C}$
$E_{rec}$	Reverse recovery energy		48	mJ
$R_{th(j-c)}$	Thermal resistance(1 device)	IGBT	0.099	$^\circ\text{C}/\text{W}$
		FWD	0.19	$^\circ\text{C}/\text{W}$
$R_{th(c-f)}$	Contact thermal resistance (1 device)	With thermal compound	0.035	$^\circ\text{C}/\text{W}$
$W_t$	Weight		300	g
Outline	454H3P			

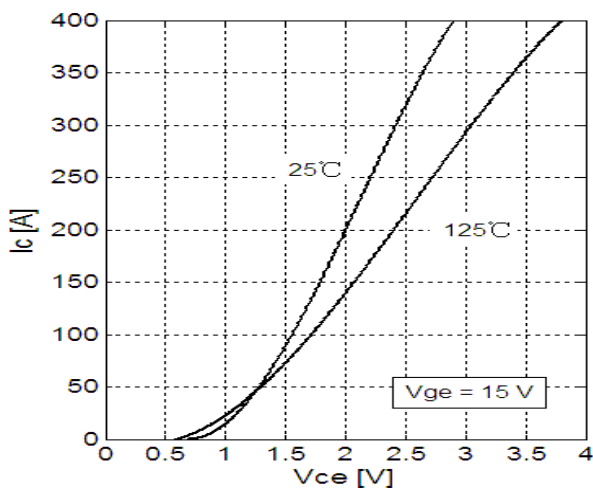


Fig 1. IGBT Typical Output Characteristics

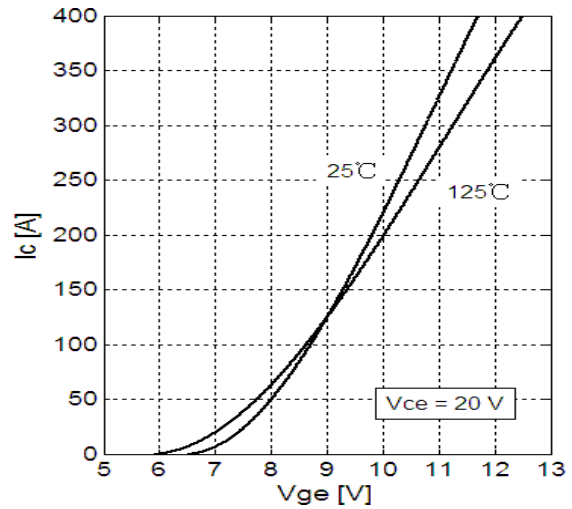


Fig 2. IGBT Typical Transfer Characteristics

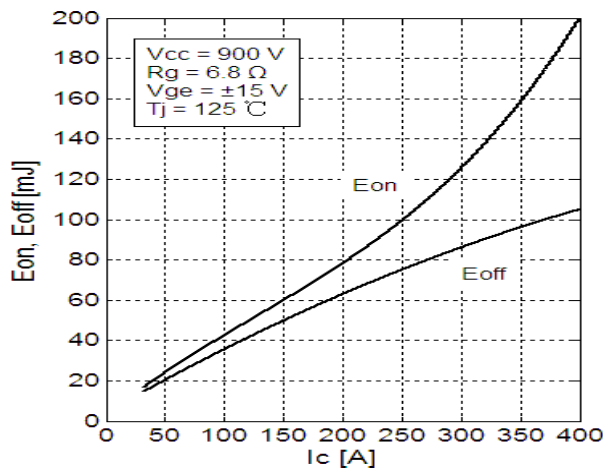


Fig 3. IGBT Switching Loss vs. Collector Current

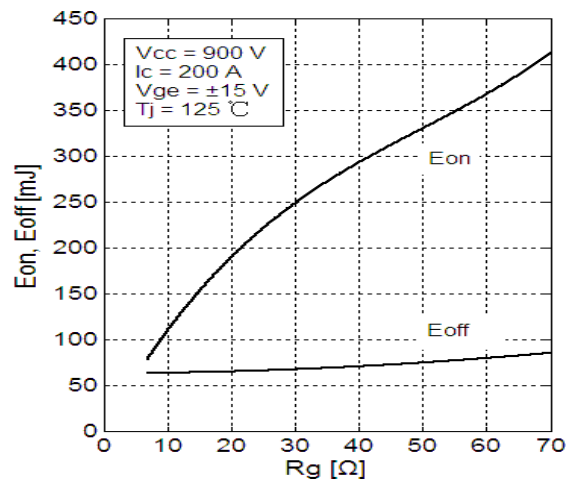
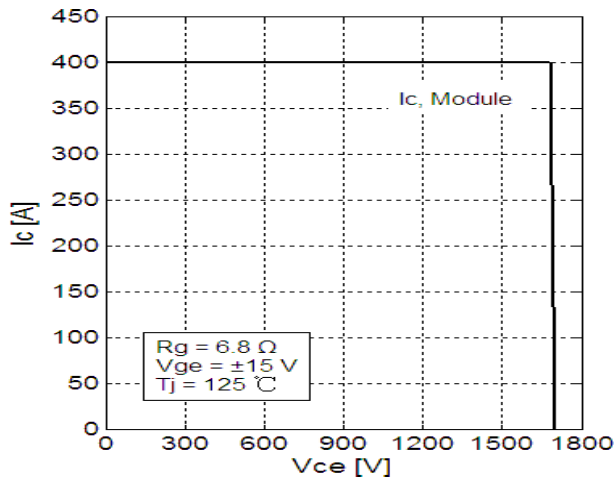
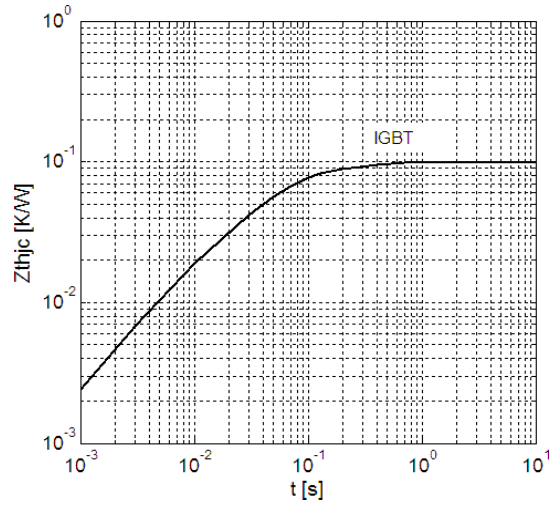


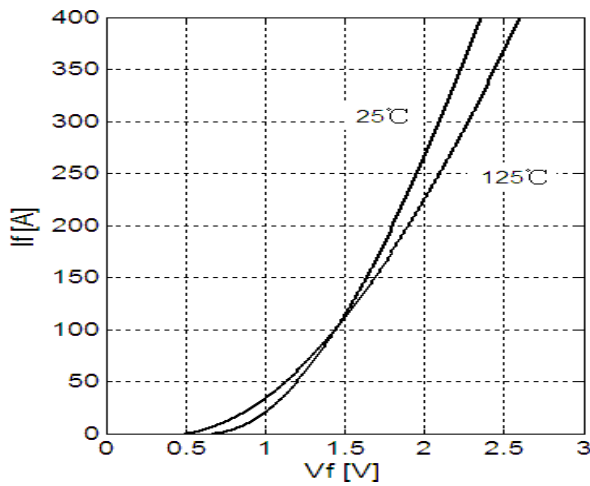
Fig 4. IGBT Switching Loss vs. Gate Resistor



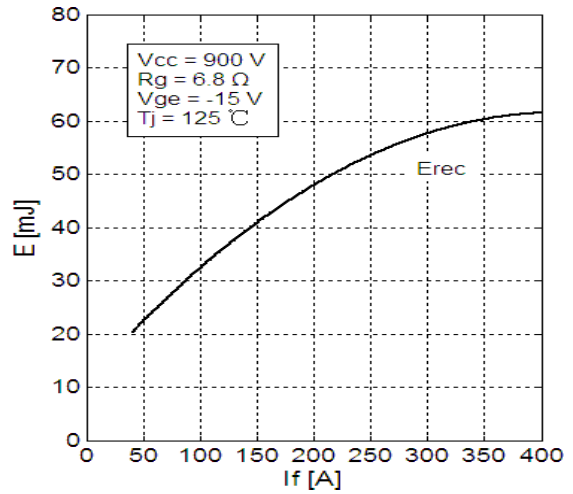
**Fig 5. RBSOA**



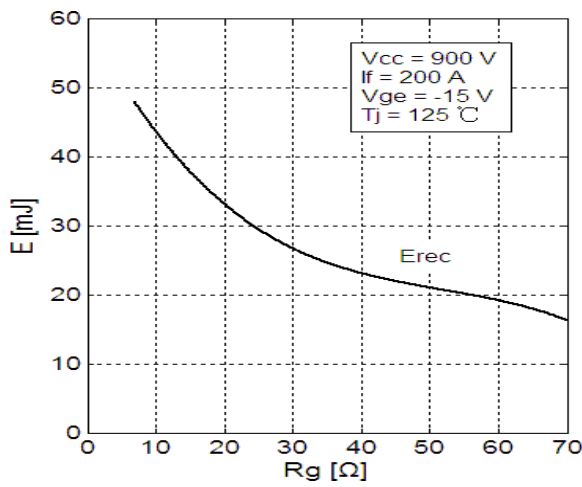
**Fig 6. IGBT Transient Thermal Impedance**



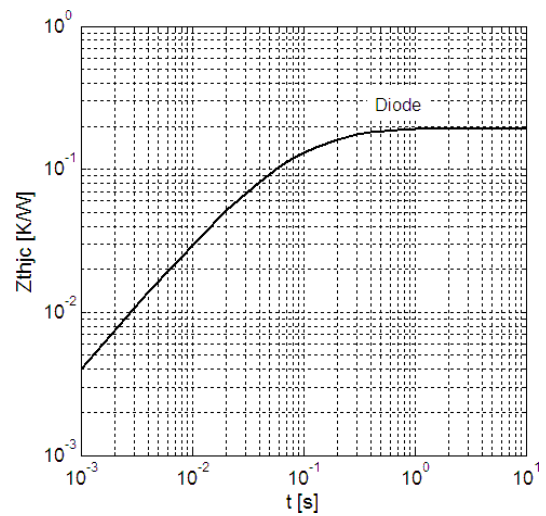
**Fig 7. Forward Characteristics of Diode**



**Fig 8. Diode Switching Loss vs. Collector Current**

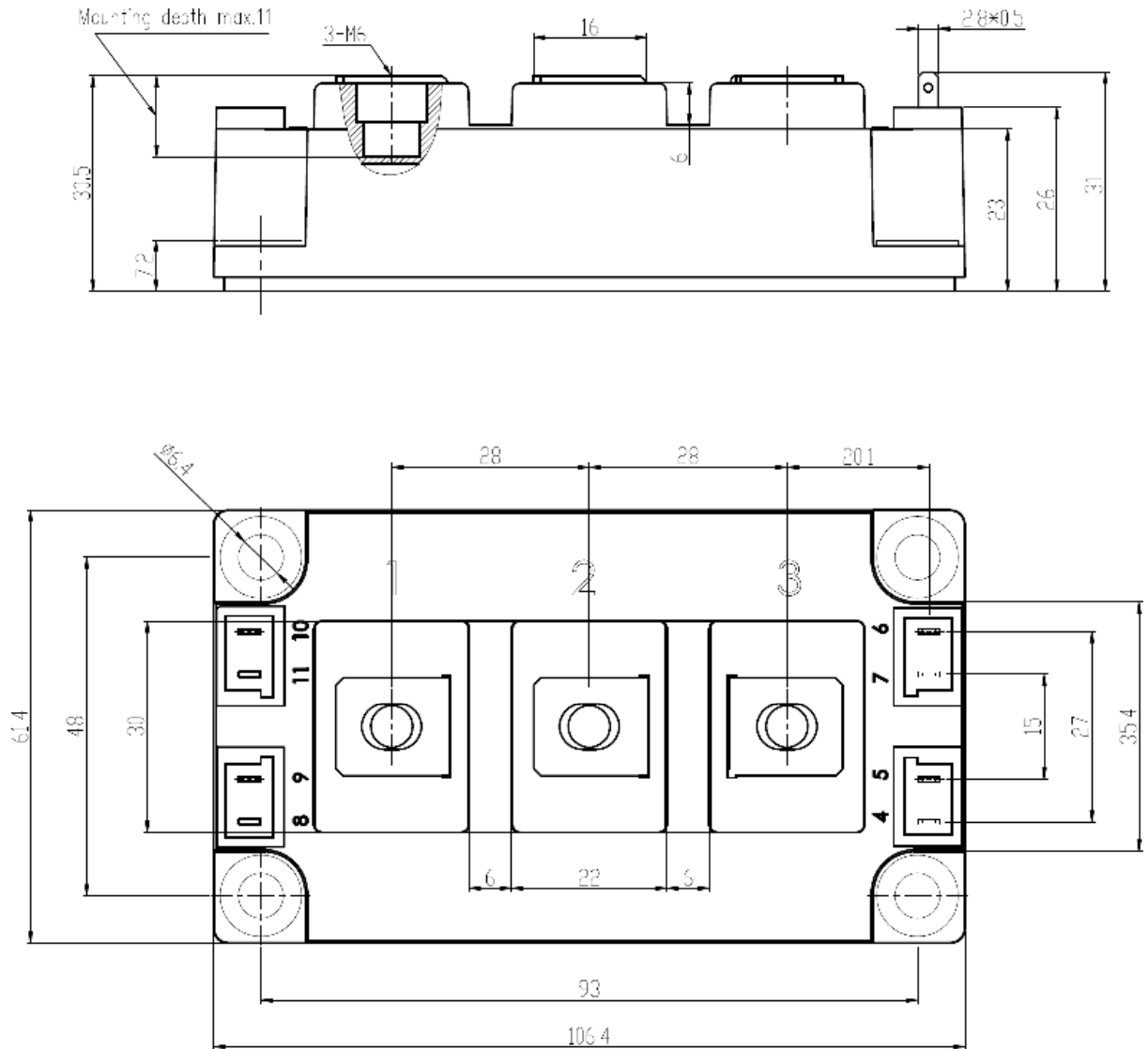


**Fig 9. Diode Switching Loss vs. Gate Resistor**



**Fig 10. Diode Transient Thermal Impedance**

Outline:



*Scomes srl reserves the right to change any specification without notice*

*issue:apr-2024*